

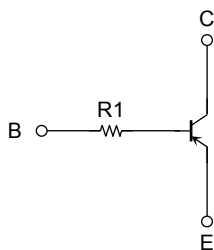
TOSHIBA Transistor Silicon PNP Epitaxial Type (PCT process) (Bias Resistor Built-in Transistor)

## RN2970HFE, RN2971HFE

Switching, Inverter Circuit, Interface Circuit and  
Driver Circuit Applications

- Two devices are incorporated into an Extreme-Super-Mini (6-pin) package.
- Incorporating a bias resistor into a transistor reduces parts count. Reducing the parts count enables the manufacture of ever more compact equipment and lowers assembly cost.
- Complementary to RN1970HFE, RN1971HFE

### Equivalent Circuit and Bias Resistor Values



### Absolute Maximum Ratings (Ta = 25°C) (Q1, Q2 common)

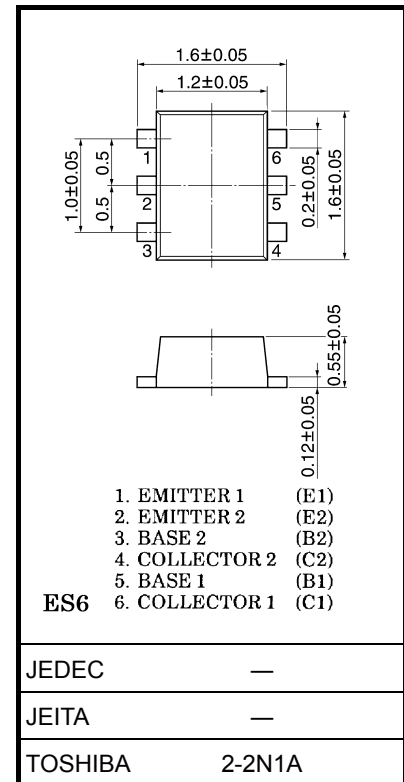
Characteristics	Symbol	Rating	Unit
Collector-base voltage	$V_{CBO}$	-30	V
Collector-emitter voltage	$V_{CEO}$	-30	V
Emitter-base voltage	$V_{EBO}$	-5	V
Collector current	$I_C$	-100	mA
Collector power dissipation	$P_C$ (Note 1)	100	mW
Junction temperature	$T_j$	150	°C
Storage temperature range	$T_{stg}$	-55~150	°C

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

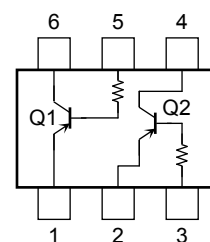
Note 1: Total rating

Unit: mm



Weight: 0.003g (typ.)

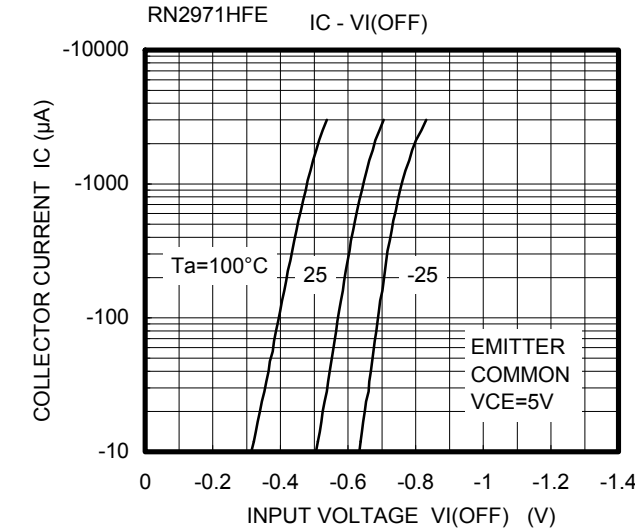
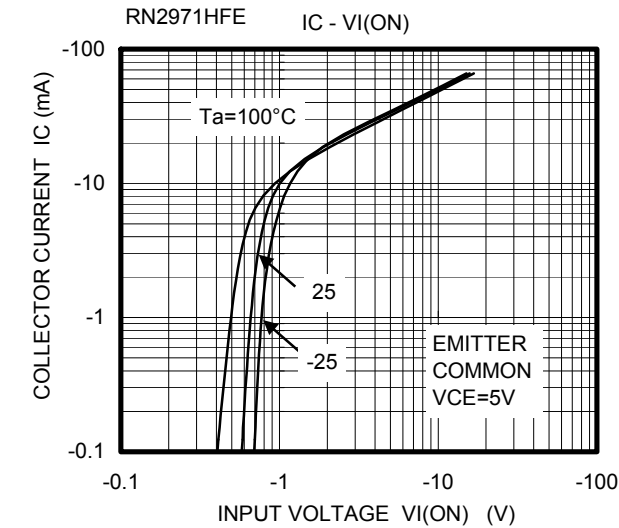
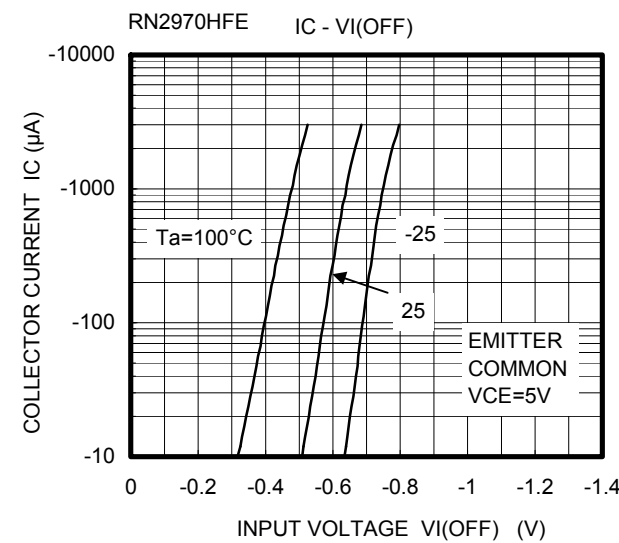
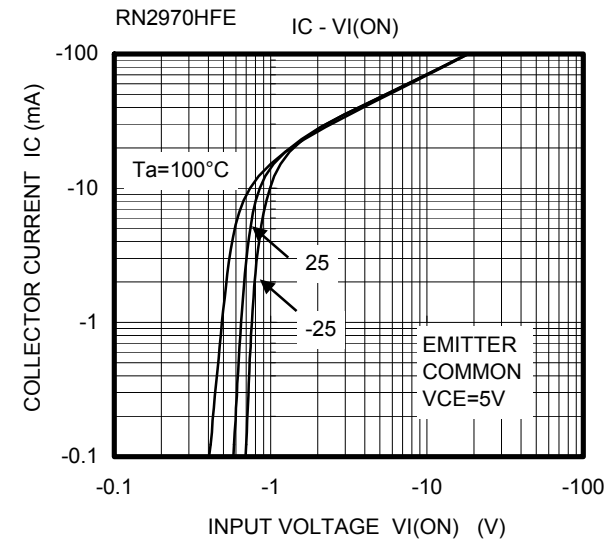
### Equivalent Circuit (top view)



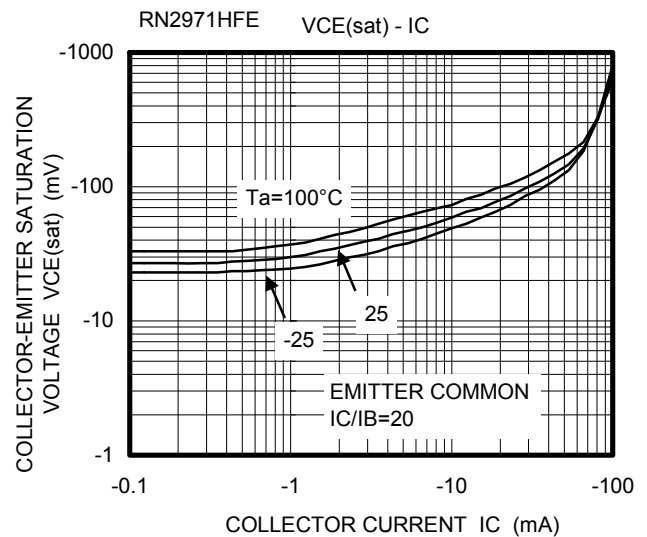
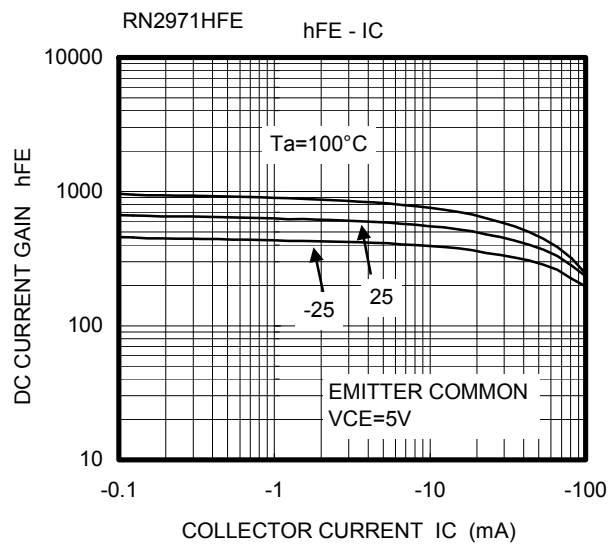
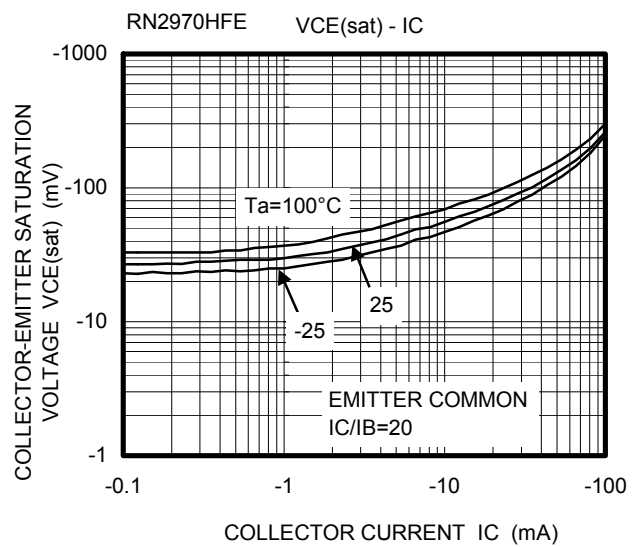
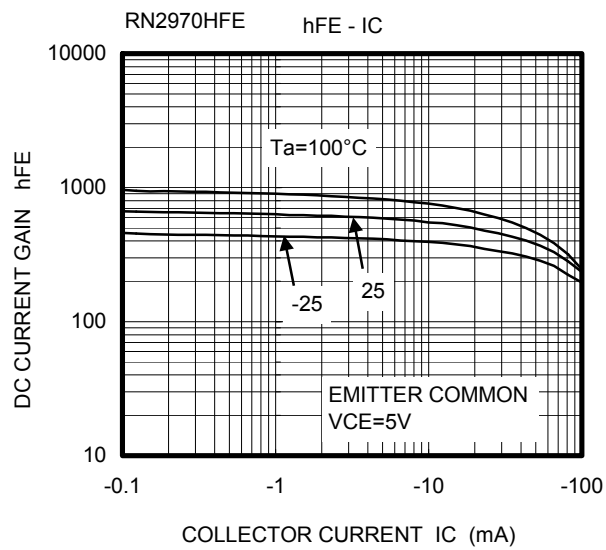
**Electrical Characteristics (Ta = 25°C) (Q1, Q2 common)**

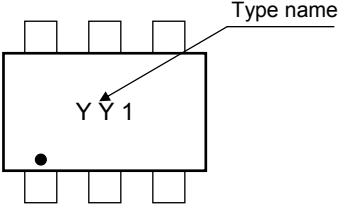
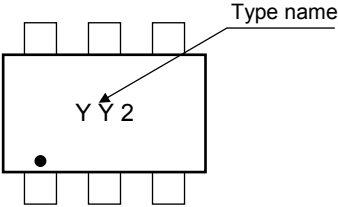
Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit
Collector cut-off current		$I_{CBO}$	$V_{CB} = -30\text{ V}, I_E = 0$	—	—	-100	nA
Emitter cut-off current		$I_{EBO}$	$V_{EB} = -5\text{ V}, I_C = 0$	—	—	-100	nA
DC current gain		$h_{FE}$	$V_{CE} = -5\text{ V}, I_C = -1\text{ mA}$	300	—	—	
Collector-emitter saturation voltage		$V_{CE(sat)}$	$I_C = -5\text{ mA}, I_B = -0.25\text{ mA}$	—	-0.06	-0.15	V
Transition frequency		$f_T$	$V_{CE} = -10\text{ V}, I_C = -5\text{ mA}$	—	200	—	MHz
Collector output capacitance		$C_{ob}$	$V_{CB} = -10\text{ V}, I_E = 0, f = 1\text{ MHz}$	—	3	—	pF
Input resistor	RN2970HFE	R1	—	3.76	4.7	5.64	kΩ
	RN2971HFE			8	10	12	

Q1, Q2 Common



## Q1, Q2 Common



Type Name	Marking
RN2970HFE	 <p>The diagram shows a rectangular component with six pins (three on top, three on bottom). Inside the rectangle, the text 'Y Y 1' is printed. A small dot is located at the bottom left of the rectangle. An arrow points from the text 'Type name' to the 'Y Y' part of the marking.</p>
RN2971HFE	 <p>The diagram shows a rectangular component with six pins (three on top, three on bottom). Inside the rectangle, the text 'Y Y 2' is printed. A small dot is located at the bottom left of the rectangle. An arrow points from the text 'Type name' to the 'Y Y' part of the marking.</p>

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20070701-EN GENERAL

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